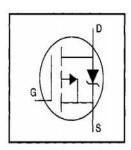
International IOR Rectifier HEXFET® POWER MOSFET

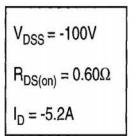
IRFI9520GPbF

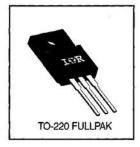
- Isolated Package
- High Voltage Isolation= 2.5KVRMS ®
- Sink to Lead Creepage Dist.= 4.8mm
- P-Channel
- 175°C Operating Temperature
- Dynamic dv/dt Rating
- · Low Thermal Resistance
- Lead-Free Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.







Absolute Maximum Ratings

	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10 V	-5.2		
I _D @ T _C = 100°C	Continuous Drain Current, VGS @ -10 V	-3.6	A	
I _{DM}	Pulsed Drain Current ①	-21		
P _D @ T _C = 25°C	Power Dissipation	37	W	
	Linear Derating Factor	0.24	W/°C	
V _{GS}	Gate-to-Source Voltage	±20	V	
Eas	Single Pulse Avalanche Energy ②	300	mJ	
I _{AR}	Avalanche Current ①	-5.2	A	
EAR	Repetitive Avalanche Energy ①	3.7	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	-5.5	V/ns	
TJ	Operating Junction and	-55 to +175		
TSTG	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)		

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units	
Rыс	Junction-to-Case		_	4.1	°C/W	
Reja	Junction-to-Ambient		_	65		

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-100	-	_	٧	V _{GS} =0V, I _D =-250μA
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	2-	-0.10	-	V/°C	Reference to 25°C, Ip=-1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	_		0.60	Ω	V _{GS} =-10V, I _D =-3.1A ④
V _{GS(th)}	Gate Threshold Voltage	-2.0	_	-4.0	V	V _{DS} =V _{GS} , I _D =-250μA
g _{fs}	Forward Transconductance	1.9	-	-	S	V _{DS} =-50V, I _D =-3.1A ④
I _{DSS}	Drain-to-Source Leakage Current	-	-	-100	μА	V _{DS} =-100V, V _{GS} =0V
1055	Dialii-to-Source Leakage Current	_	_	-500		V _{DS} =-80V, V _{GS} =0V, T _J =150°C
Igss	Gate-to-Source Forward Leakage	-	19 (-100	nA	V _{GS} =-20V
IGSS	Gate-to-Source Reverse Leakage	-	_	100	nA	V _{GS} =20V
Q_g	Total Gate Charge	-	-	18		I _D =-6.8A
Qgs	Gate-to-Source Charge	-	_	3.0	nC	V _{DS} =-80V
Q _{gd}	Gate-to-Drain ("Miller") Charge	_	_	9.0		V _{GS} =-10V See Fig. 6 and 13 @
t _{d(on)}	Turn-On Delay Time	_	9.6			V _{DD} =-50V
tr	Rise Time	_	29		ns	I _D =-6.8A
td(off)	Turn-Off Delay Time	-	21	_	113	R _G =18Ω
tı	Fall Time	_	25			R _D =7.1Ω See Figure 10 @
LD	Internal Drain Inductance	-	4.5		nН	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance		7.5	—s	1001	from package and center of die contact
Ciss	Input Capacitance	-	390	النسا		V _{GS} =0V
Coss	Output Capacitance	-	170	8—	pF	V _{DS} =-25V
Crss	Reverse Transfer Capacitance		45	-		f=1.0MHz See Figure 5
C	Drain to Sink Capacitance	_	12	8_11	pF	f=1.0MHz
						area

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)	-	-	-5.2	Α	MOSFET symbol showing the integral reverse p-n junction diode.
I _{SM}	Pulsed Source Current (Body Diode) ①	_	-	-21		
V _{SD}	Diode Forward Voltage	10-0		-6.3	٧	T _J =25°C, I _S =-5.2A, V _{GS} =0V @
trr	Reverse Recovery Time		100	200	ns	T _J =25°C, I _F =-6.8A
Qrr	Reverse Recovery Charge		0.33	0.66	μC	di/dt=100A/μs Φ
ton	Forward Turn-On Time	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lp)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ I_{SD}≤-6.8A, di/dt≤110A/μs, V_{DD}≤V(BR)DSS, T_J≤175°C
- ⑤ t=60s, f=60Hz

- 2 V_{DD}=-25V, starting T_J=25°C, L=16mH R_G=25 Ω , I_{AS}=-5.2A (See Figure 12)
- ④ Pulse width ≤ 300 μs; duty cycle ≤2%.

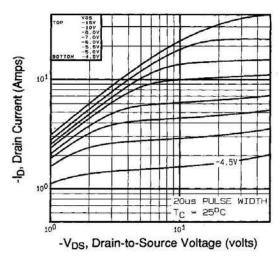


Fig 1. Typical Output Characteristics, T_C=25°C

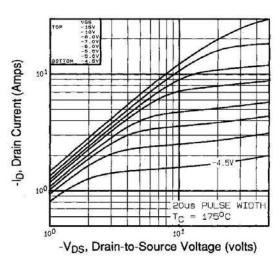


Fig 2. Typical Output Characteristics, Tc=175°C

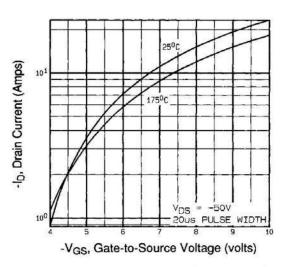


Fig 3. Typical Transfer Characteristics

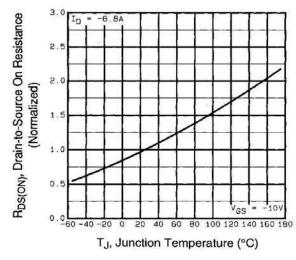


Fig 4. Normalized On-Resistance Vs. Temperature

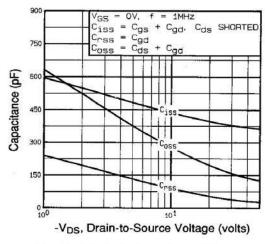


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

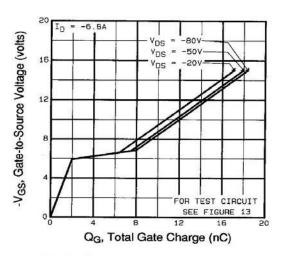


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

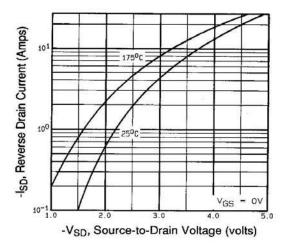


Fig 7. Typical Source-Drain Diode Forward Voltage

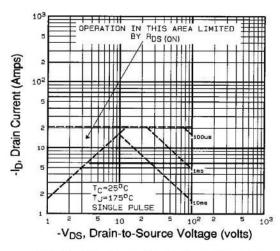


Fig 8. Maximum Safe Operating Area

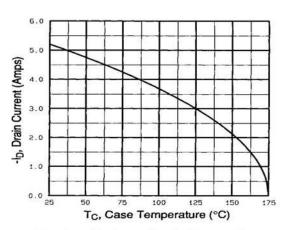


Fig 9. Maximum Drain Current Vs. Case Temperature

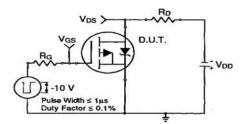


Fig 10a. Switching Time Test Circuit

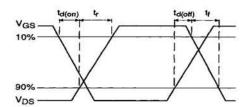


Fig 10b. Switching Time Waveforms

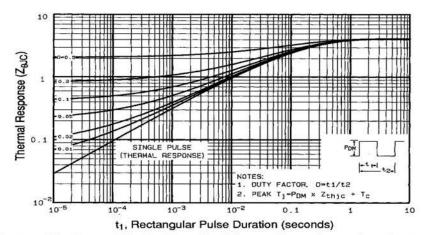


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

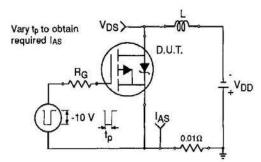


Fig 12a. Unclamped Inductive Test Circuit

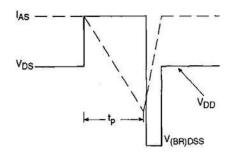


Fig 12b. Unclamped Inductive Waveforms

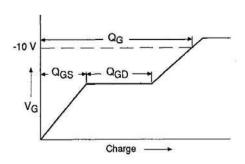


Fig 13a. Basic Gate Charge Waveform

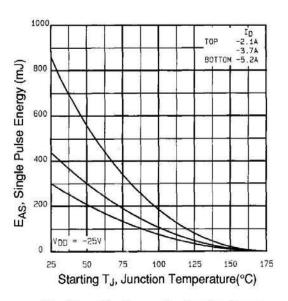


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

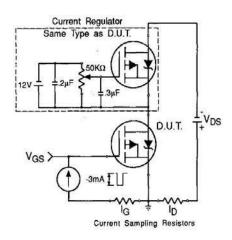
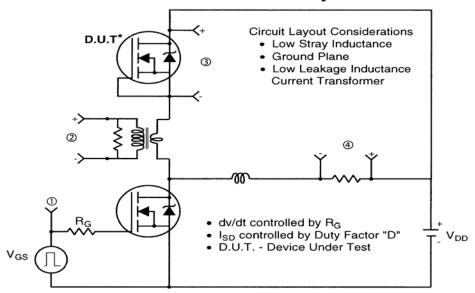
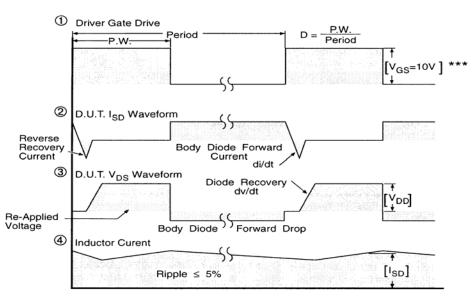


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

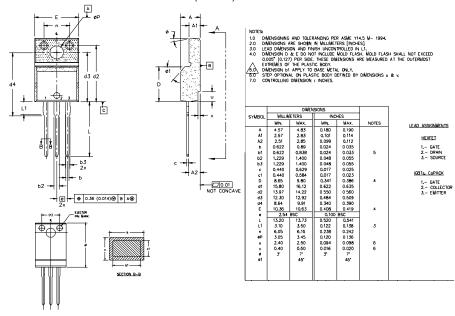
Fig 14. For P-Channel HEXFETS

International

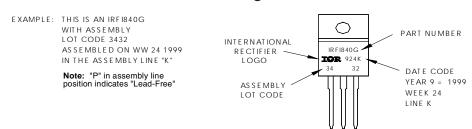
TOR Rectifier

TO-220 Full-Pak Package Outline

Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information



Data and specifications subject to change without notice.



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